

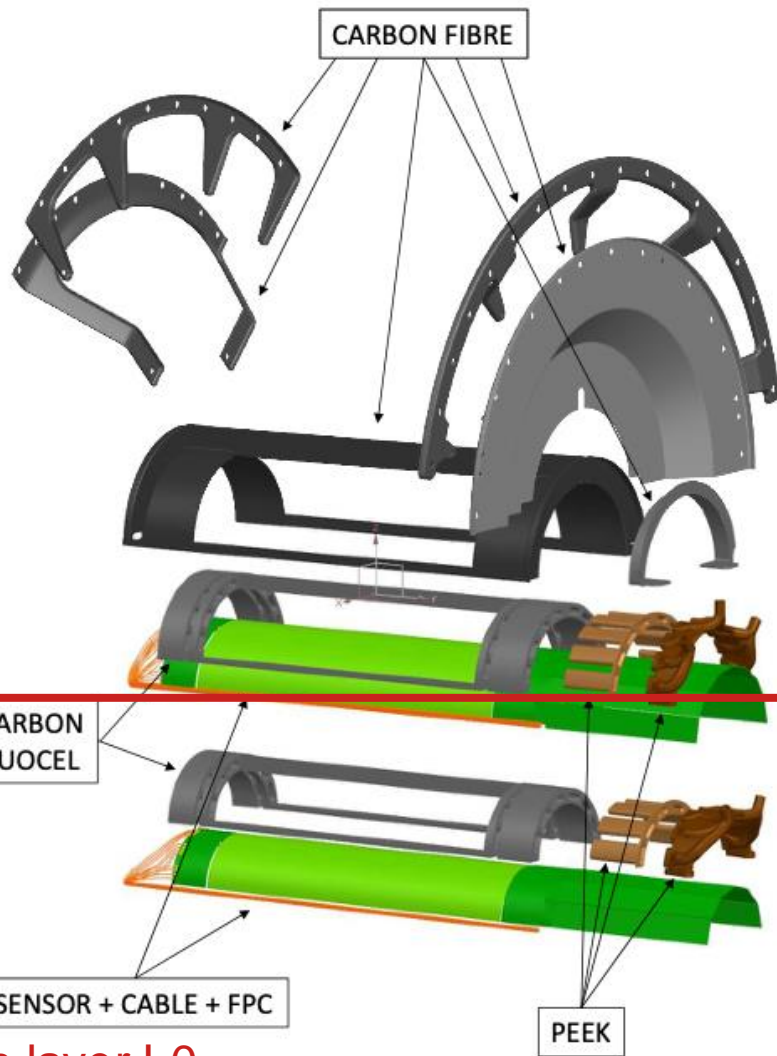
Vibrational/Thermal analysis of L0-L1

Material properties derived from ALICE-TDR-021

Uniform isotropic silicon foil of 50 μm

Bonded contact is considered and the glue in between

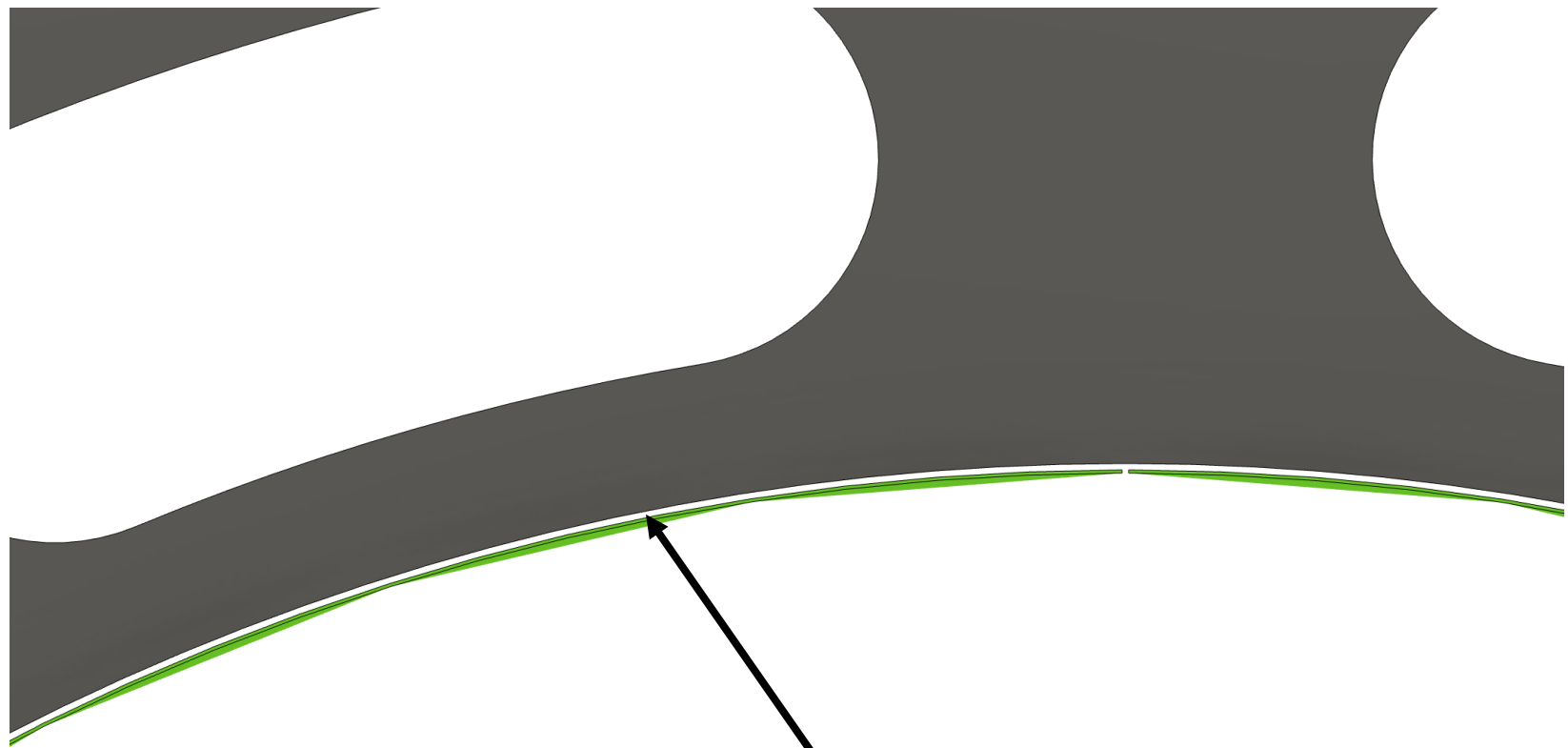
INFN- TIFPA



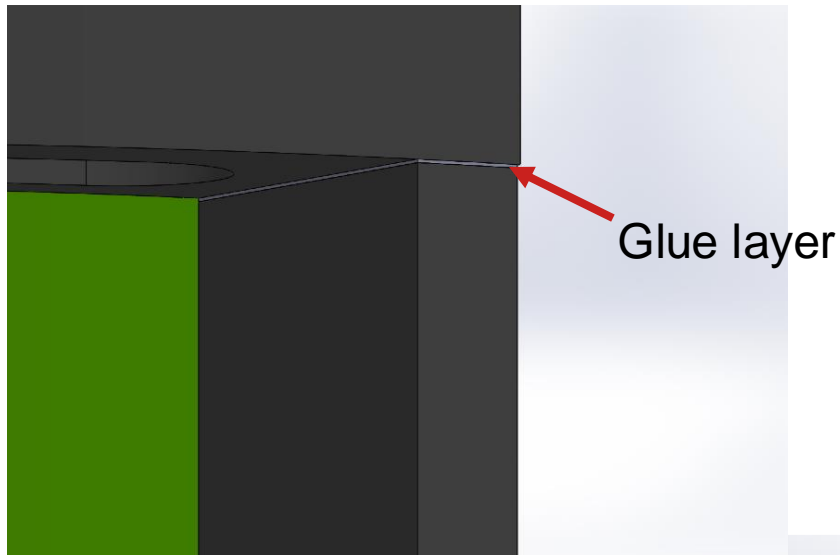
L0 model



Start with layer L0



Intermediate glue layer

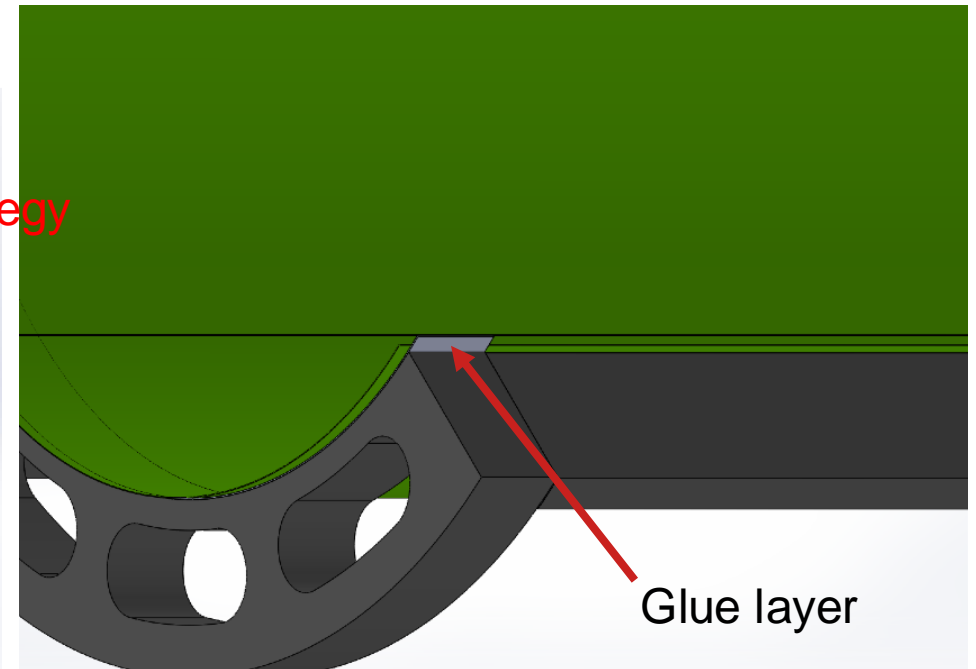
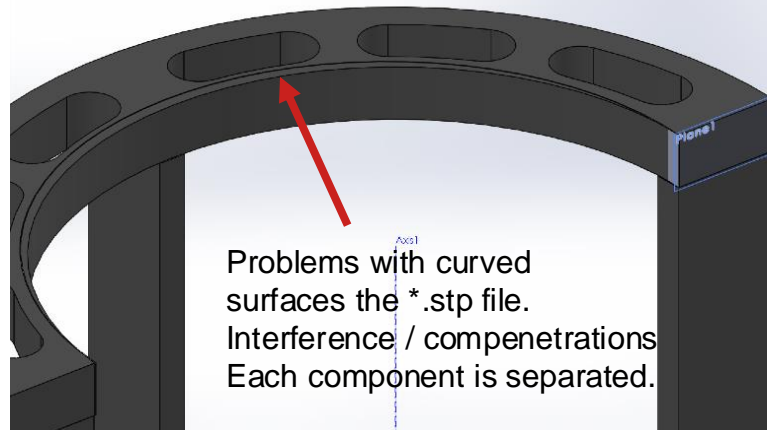


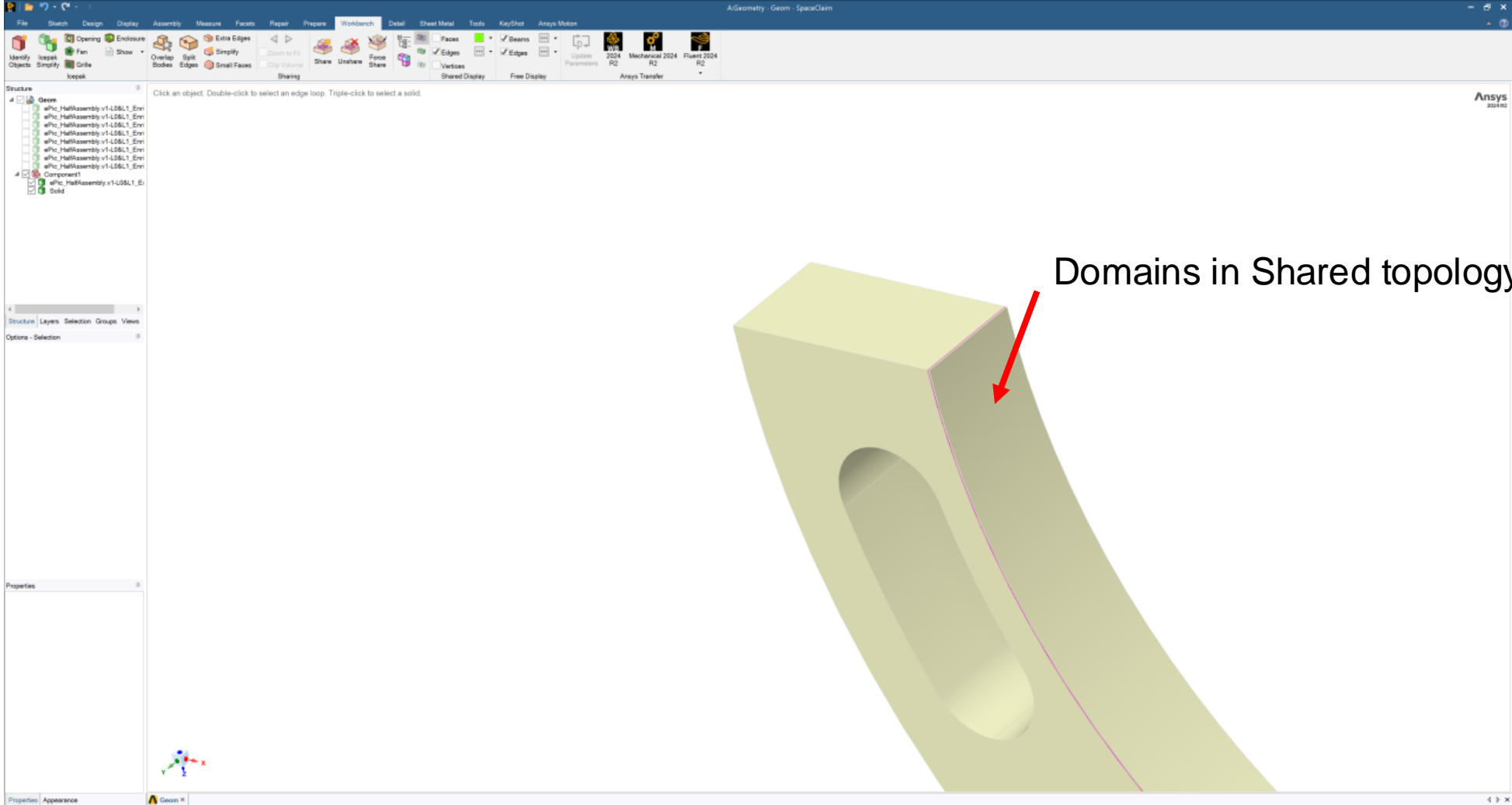
The overall mesh should be connected.
Use of solid elements also for thin layers.

How to include a glue layer to build a connected mesh

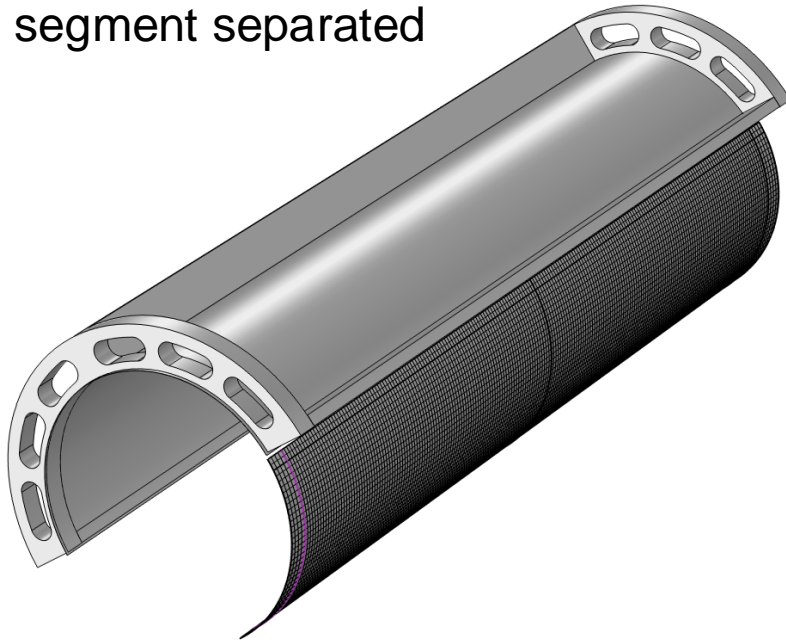
Maybe a reconstruction of the geometry in FEA is needed.

To be solved in the SpaceClaim environment
Available in Ansys with a Shared Topology strategy



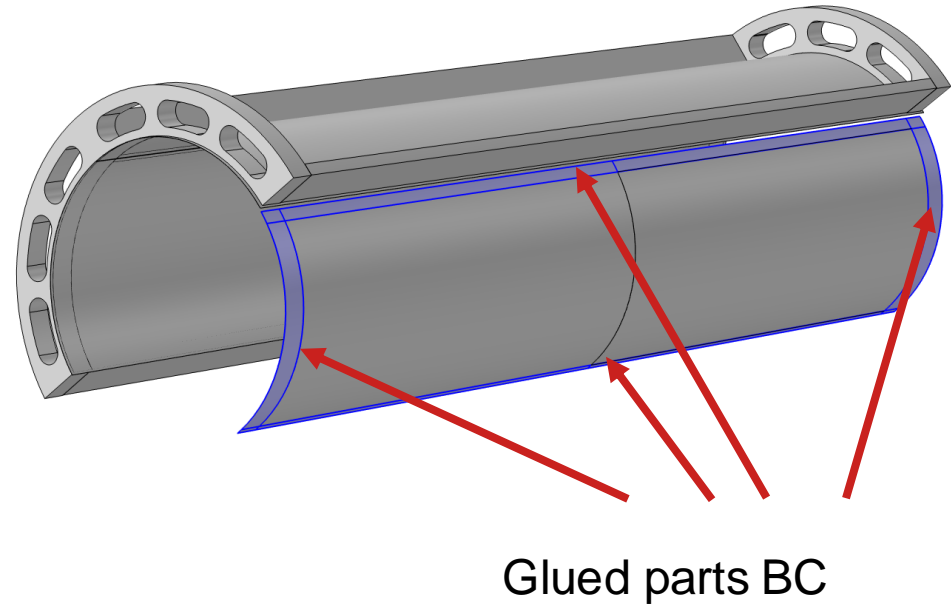


Mesh and simulation
of $\frac{1}{4}$ of silicon layer.
4 segment separated



Bending stress is not taken into account.

Fixed boundary conditions BCs.
Projection of the H-rings and
Longeron surfaces.



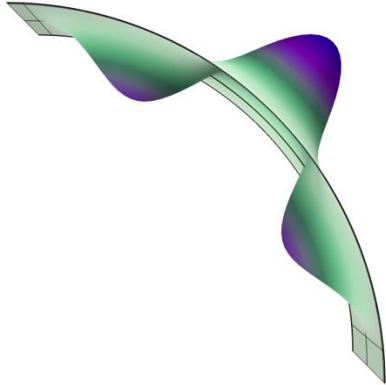
INFN Modal analysis of the silicon foil

Modes above 1k Hz - BCs too rigid?

Eigenfrequency=1149.317543 Hz

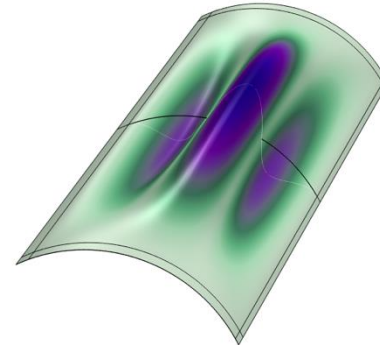
Surface: Displacement magnitude (μm)

y
↑
z → x



Eigenfrequency=1149.317543 Hz

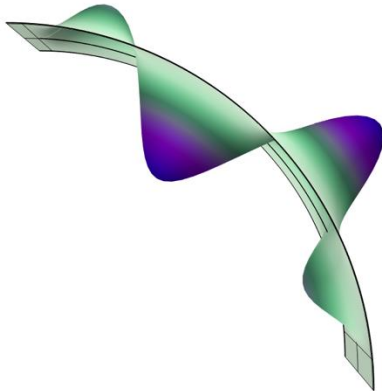
Surface: Displacement magnitude (μm)



Eigenfrequency=1267.83963 Hz

Surface: Displacement magnitude (μm)

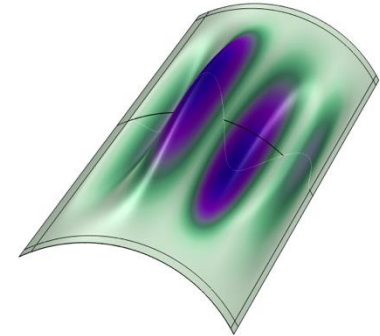
y
↑
z → x



Eigenfrequency=1267.83963 Hz

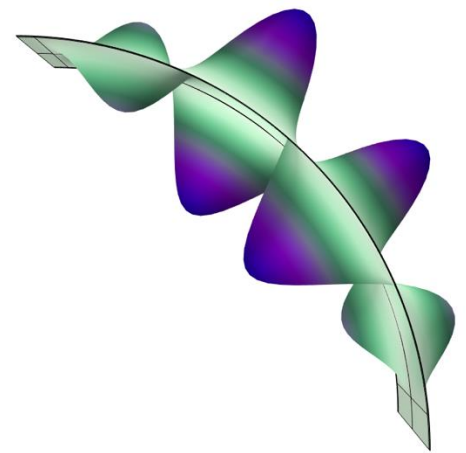
Surface: Displacement magnitude (μm)

x
↑
z → y



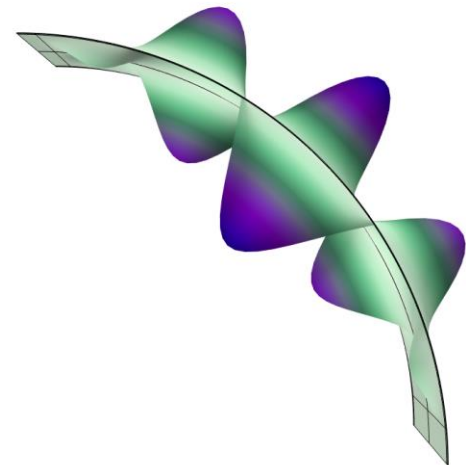
Eigenfrequency=1599.232594 Hz

Surface: Displacement magnitude (μm)



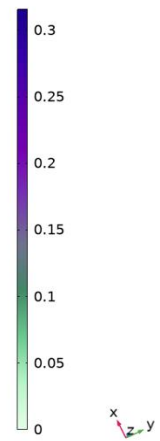
Eigenfrequency=1763.641803 Hz

Surface: Displacement magnitude (μm)



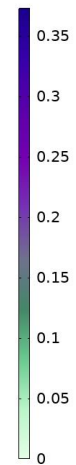
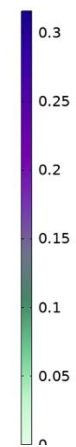
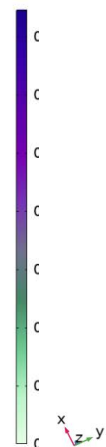
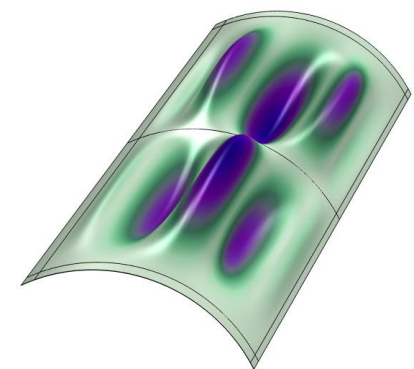
Eigenfrequency=1599.232594 Hz

Surface: Displacement magnitude (μm)



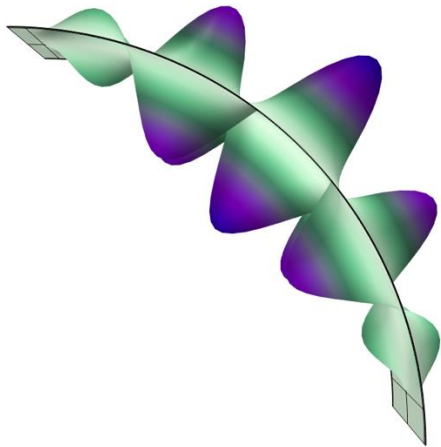
Eigenfrequency=1763.641803 Hz

Surface: Displacement magnitude (μm)



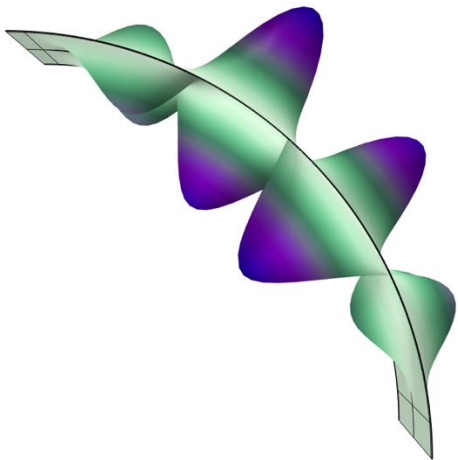
Eigenfrequency=2135.643481 Hz

Surface: Displacement magnitude (μm)



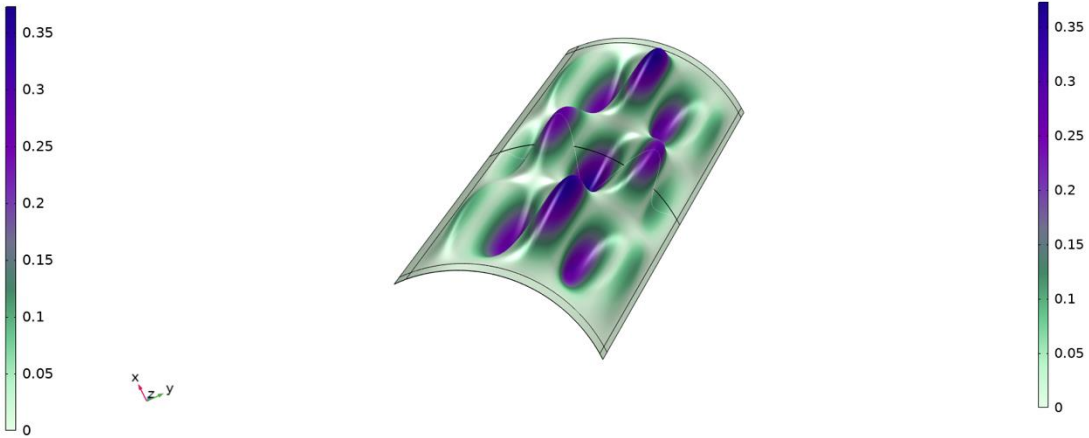
Eigenfrequency=2146.10124 Hz

Surface: Displacement magnitude (μm)



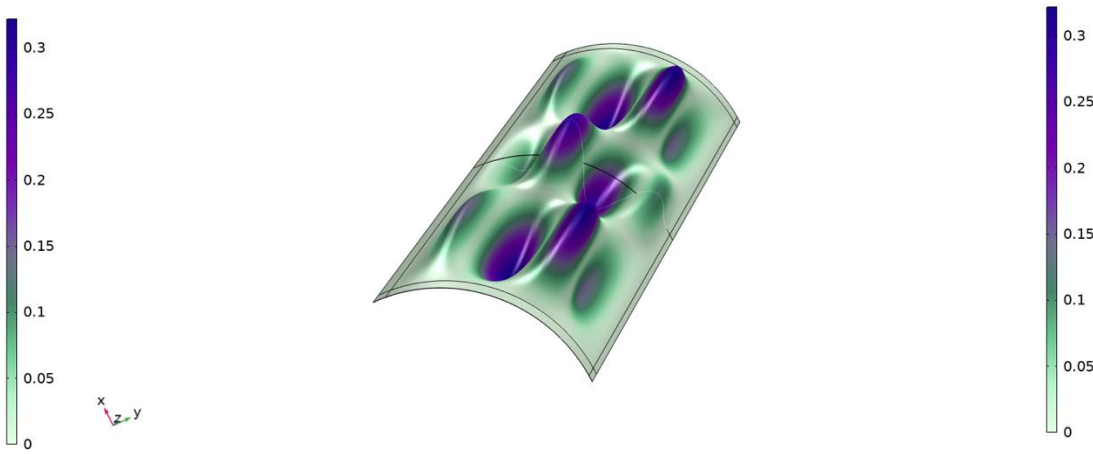
Eigenfrequency=2135.643481 Hz

Surface: Displacement magnitude (μm)

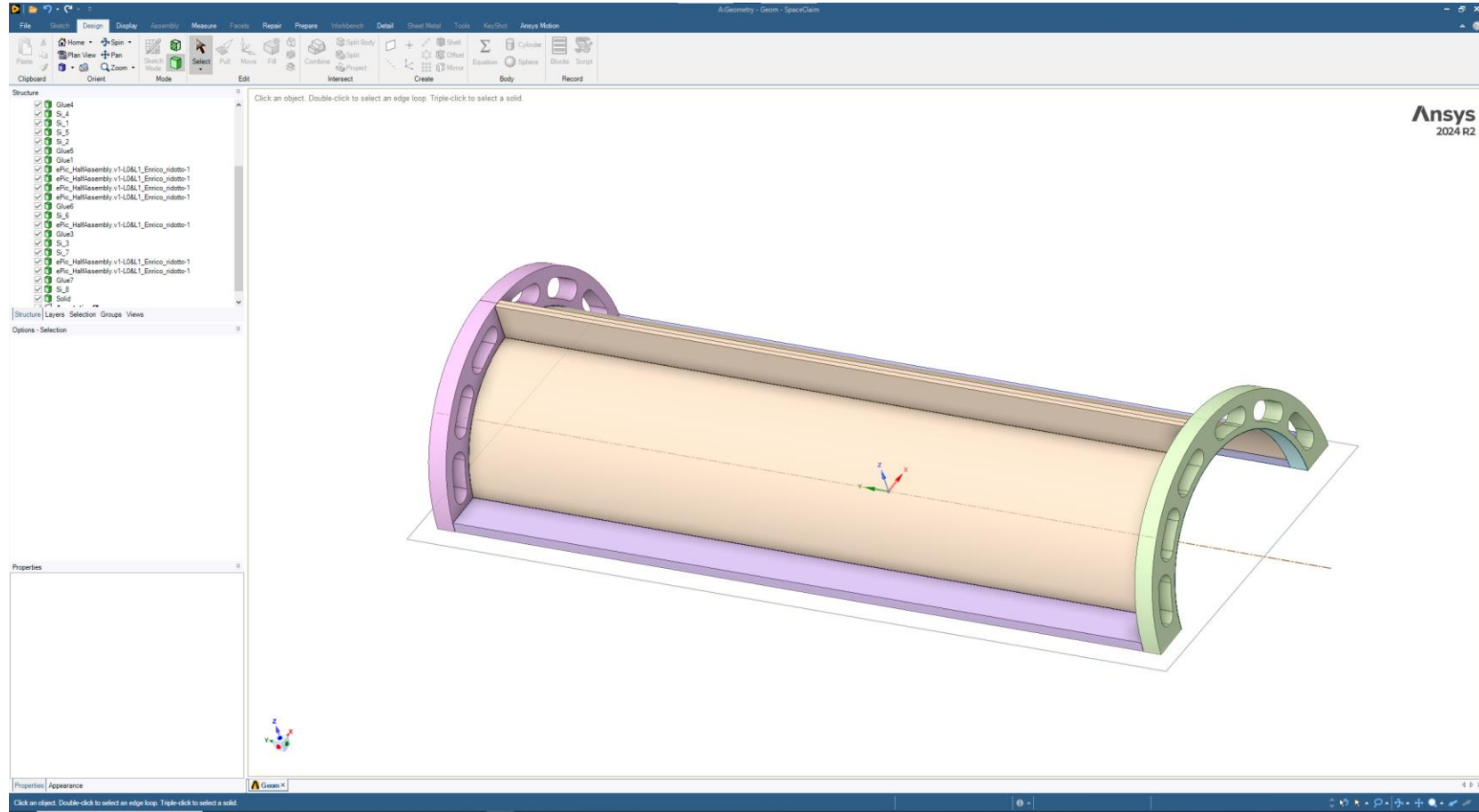


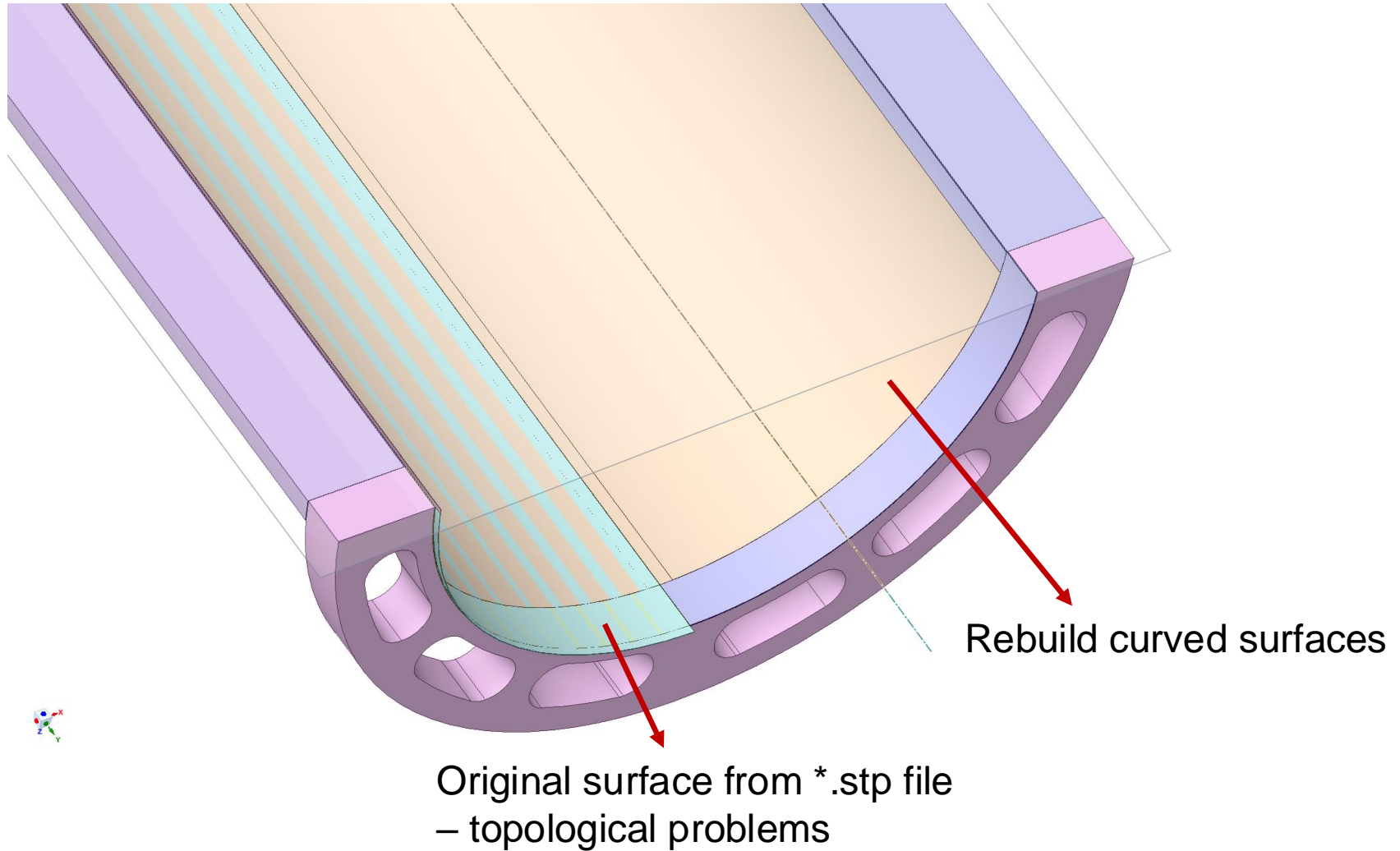
Eigenfrequency=2146.10124 Hz

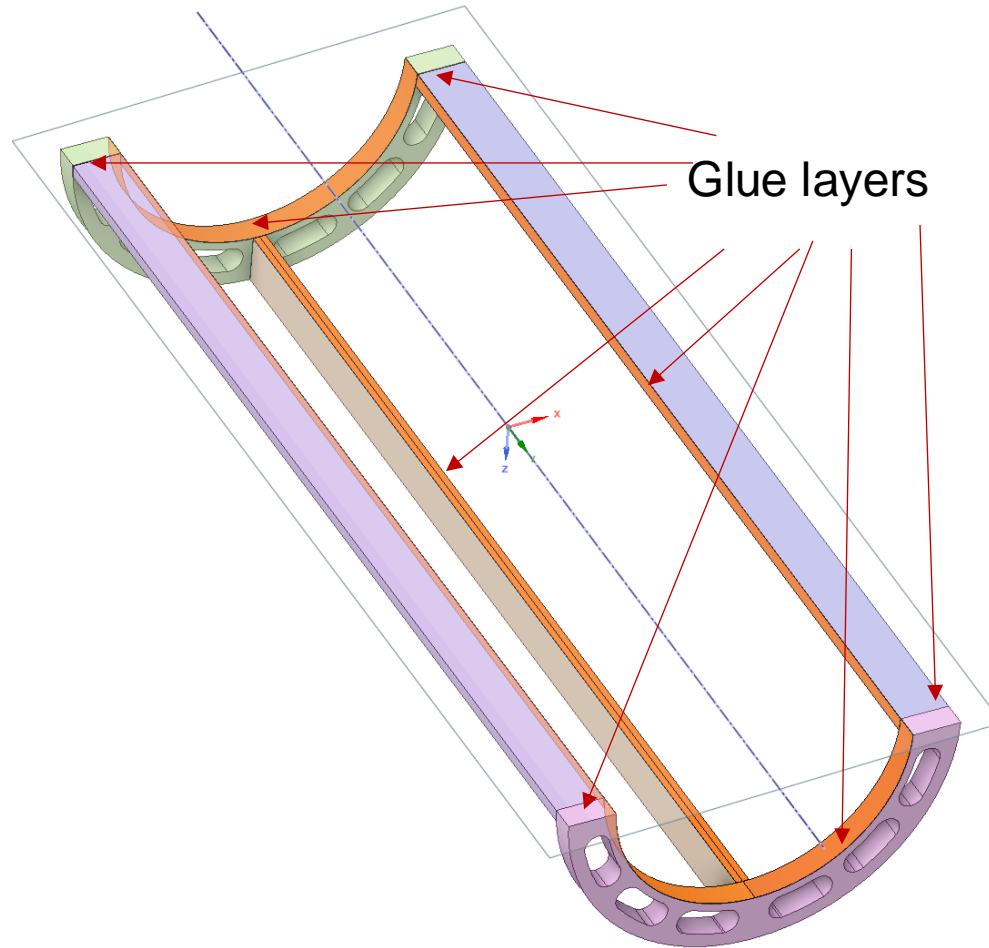
Surface: Displacement magnitude (μm)



Modal analysis ½ L0

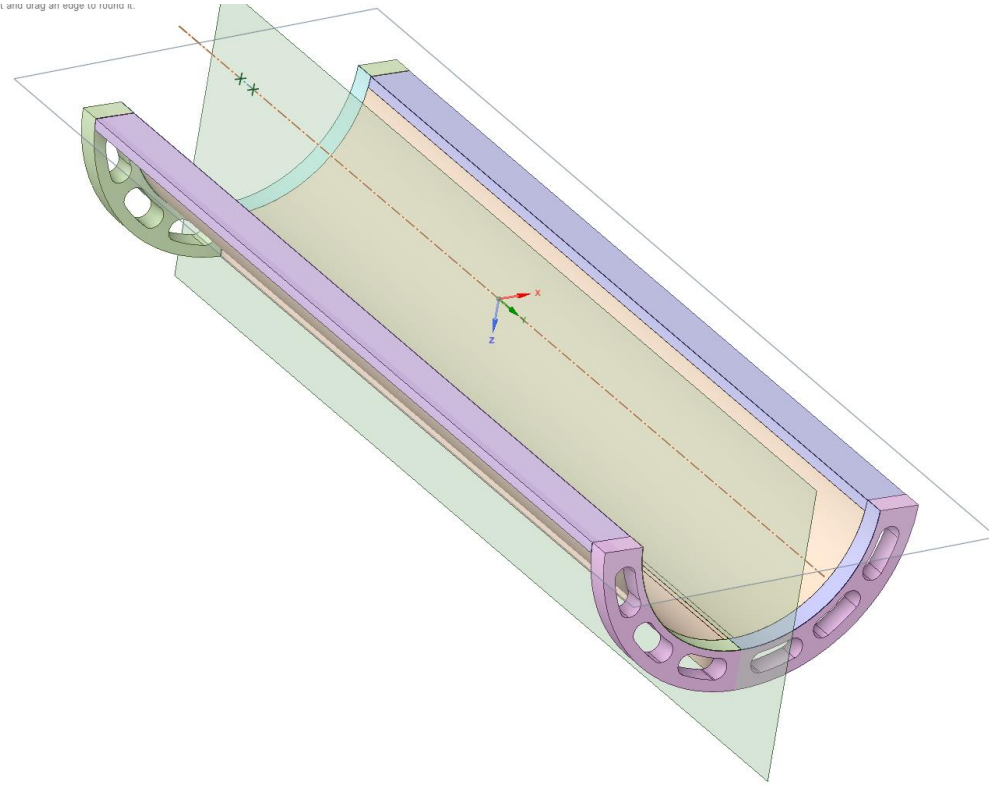




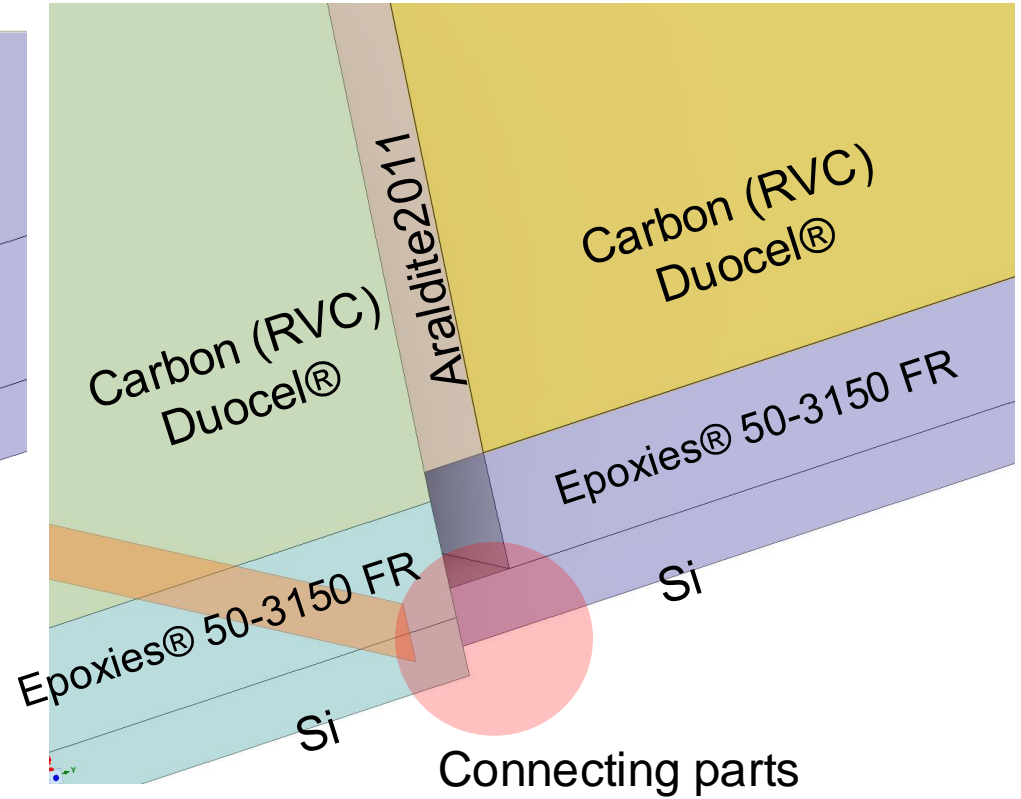
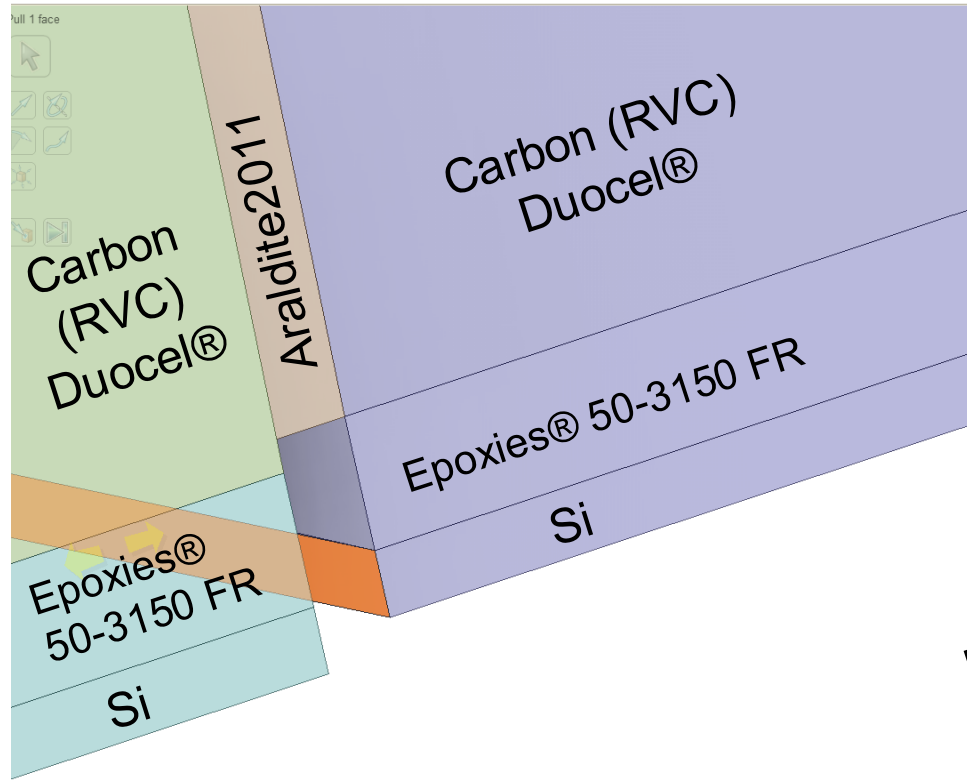


Grow of silicon layers

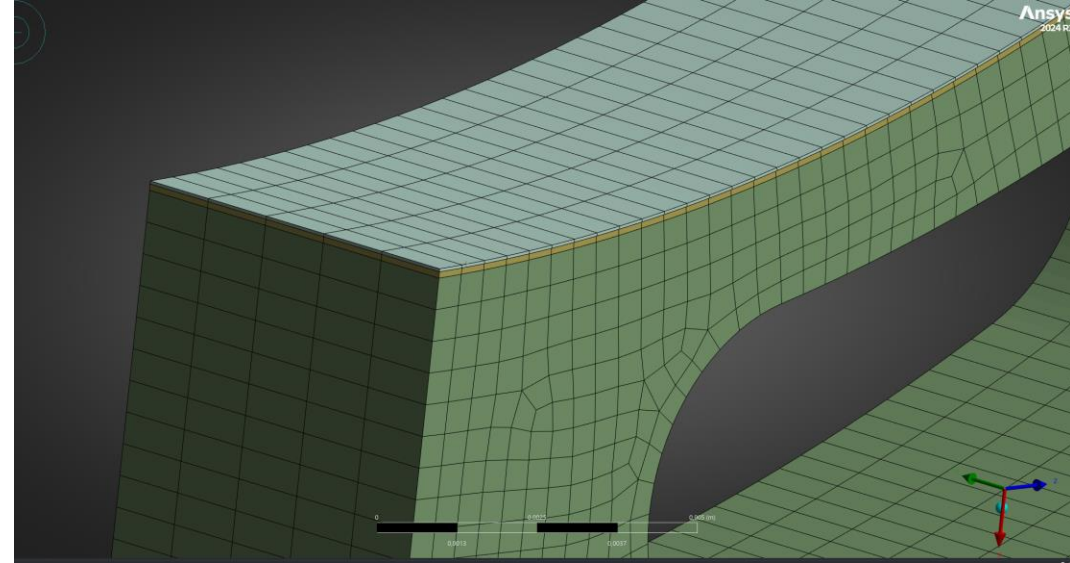
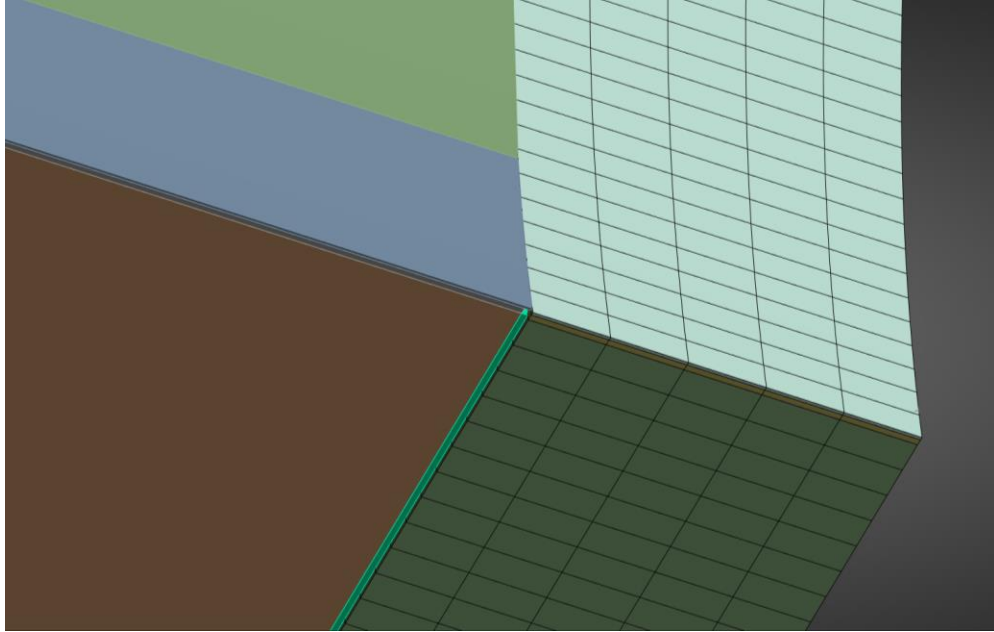
Select and drag an edge to rotate it.



Modelling strategy

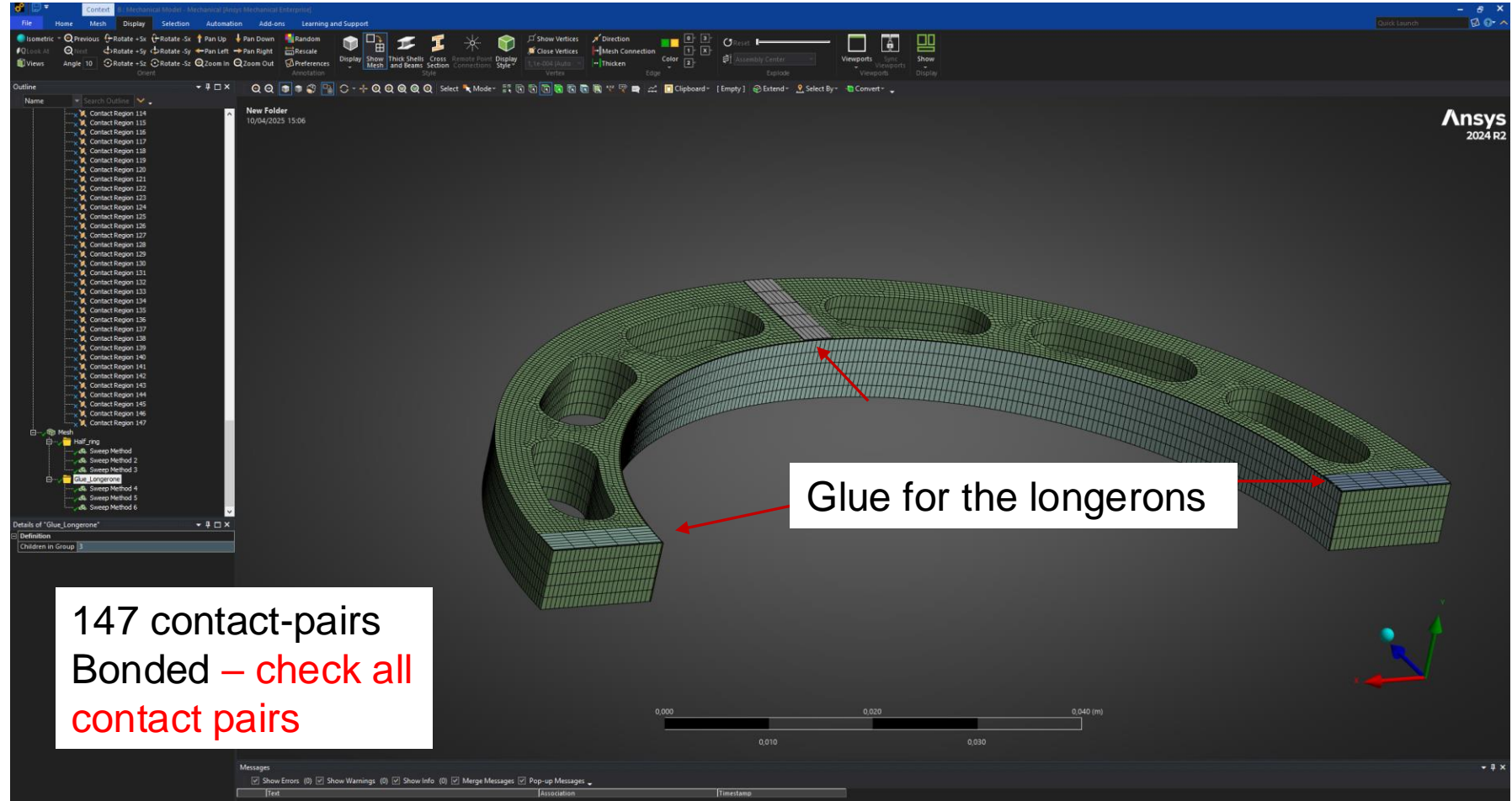


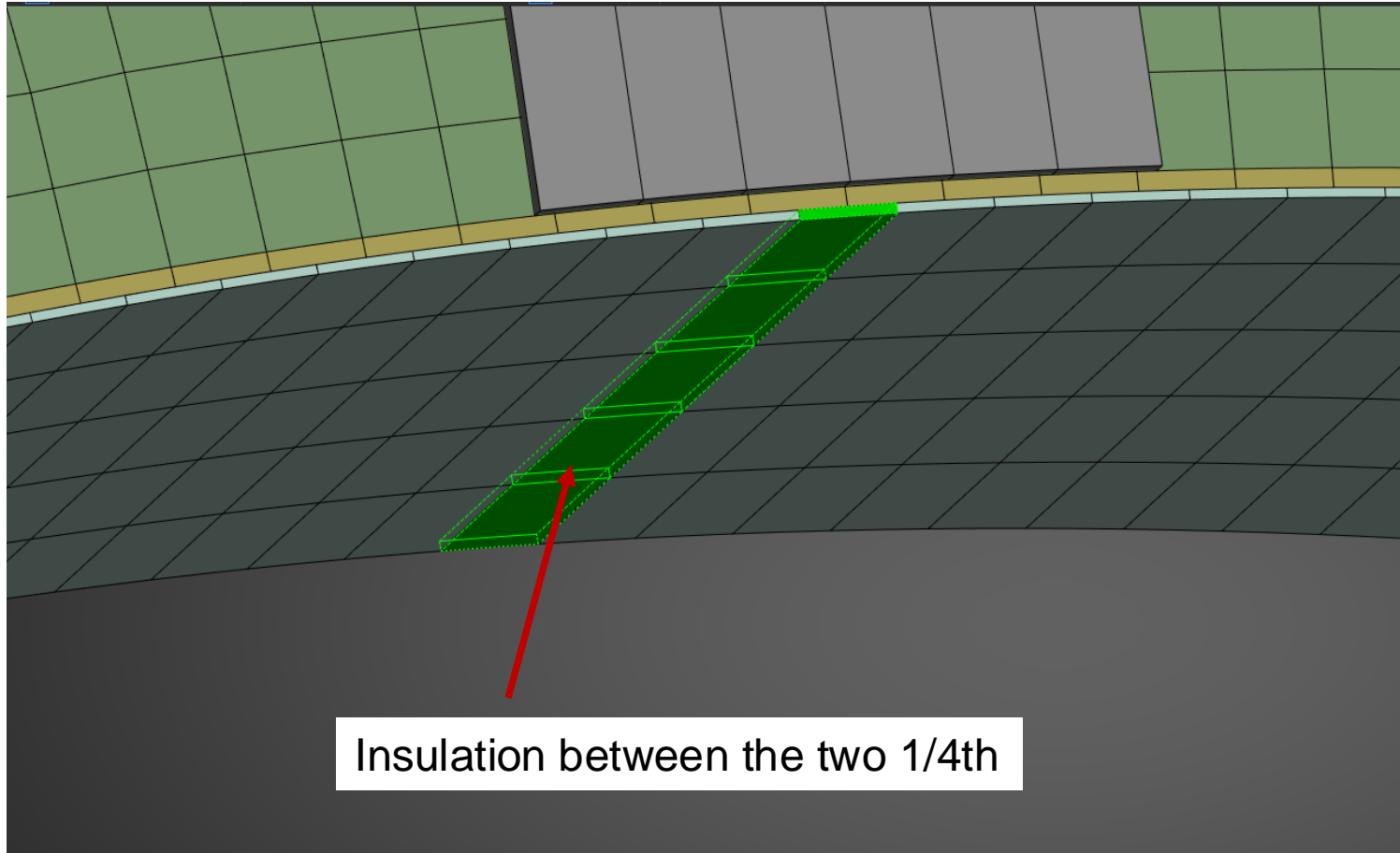
Meshing strategy



Mesh sweeping to obtain a regular mesh

Half-ring





Modelling 1/4th reduce the

